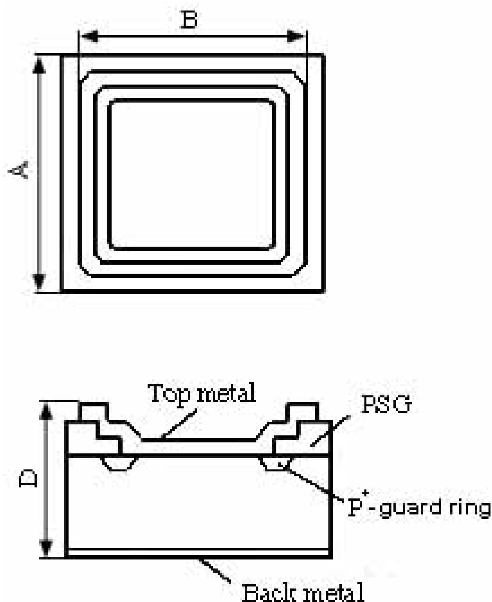
	2A/150V. Die Size-45mil.			
Electrical Characteristics	**Symbol**	**Unit**	**Spec. limit**	**Die Sort**
Breakdown Voltage @ I_R=10mA	V_{BR}	V	150	160
Average Rectified Forward Current	$I_{F(AV)}$	A	2,0	-
DC Forward Voltage @ 25˚C, I_F=2,0A	V_F	V	0,88	0,86
Maximum Reverse Current @ 25˚C, V_R=150V @ 125˚C, V_R=150V	I_R	mA	0,005 5,0	0,003 4,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	50	-
Peak Repetitive Reverse Surge Current @2,0µs, f=1kHz., T_J<175˚C.	I_{RRM}	A	1,0	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	V_{ESD}	kV	±8 (contact)	
Voltage Rate of Change	dV/dt	V/µS	10.000	
Operating Junction Temperature	T_J	˚C	175	



DIM	ITEM	µm
A_X A_y	Wafer Form Die Size	1150 1150
B_X B_y	Top Metal Size	1030 1030
D	Thickness	300max.
Scribe line Width		80

Top metal:
a) **Al-Ni-Ag** – for Soldering;
b) **Al** – for Wire Bonding.
Backside metal: **Ti-Ni-Ag**.